


<b>Search Notes</b>  	<b>Application/Control No.</b>  10501814	<b>Applicant(s)/Patent Under Reexamination</b>  HIPFEL ET AL.
	<b>Examiner</b>  STEVEN H STANDLEY	<b>Art Unit</b>  1649

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
stic search of SEQ ID NO; 2-3	5/15/08	ss
pubmed see enclosed.	5/15/08	ss
East see enclosed	5/15/08	ss

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner